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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,474	MATSUKAWA ET AL.	
Examiner	Art Unit	
Lois Zheng	1742	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventorship search	5/9/2007	LLZ	
Updated EAST search	5/9/2007	LLZ	